

-8A, -80V and -100V, 0.400 Ohm, P-Channel Power MOSFETs

These are P-Channel enhancement mode silicon gate power field effect transistors designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17511.

Ordering Information

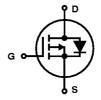
PART NUMBER	PACKAGE	BRAND
RFM8P08	TO-204AA	RFM8P08
RFM8P10	TO-204AA	RFM8P10
RFP8P08	TO-220AB	RFP8P08
RFP8P10	TO-220AB	RFP8P10

NOTE: When ordering, include the entire part number.

Features

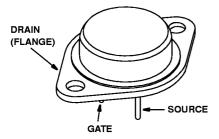
- -8A, -80V and -100V
- $r_{DS(ON)} = 0.400\Omega$
- · Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol

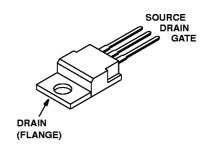


Packaging









RFM8P08, RFM8P10, RFP8P08, RFP8P10

Absolute Maximum Ratings T_C = 25°C, Unless Otherwise Specified RFP8P10 UNITS RFM8P10 RFP8P08 -80 -100 -80 -100 Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1) V_{DGR} -80 -100 -80 -100 8 8 8 8 Α 20 20 20 20 ±20 ±20 ±20 ±20 100 75 W 100 75 W/oC 0.8 8.0 0.6 0.6 Operating and Storage Temperature T_J, T_{STG} -55 to 150 -55 to 150 -55 to 150 οС -55 to 150 Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s......T_L οС 300 300 300 300 οС Package Body for 10s, See Techbrief 334 Tpkg 260 260 260 260

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_{.J} = 25^{\circ}C$ to $125^{\circ}C$.

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNITS
Drain to Source Breakdown Voltage RFM8P08, RFP8P08	BV _{DSS}	$I_D = -250 \mu A, V_{GS} = 0$				٧
RFM8P10, RFP8P10			-100			٧
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-2	-	-4	٧
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V	-	-	1	μΑ
		V _{DS} = 0.8 x Rated BV _{DSS} , V _{GS} = 0V T _J = 125°C	-	-	25	μА
Gate to Source Leakage Current	IGSS	$V_{GS} = \pm 20V, V_{DS} = 0$	-	-	±100	nA
Drain to Source On Resistance (Note 2)	r _{DS(ON)}	I _D = 8A, V _{GS} = -10V (Figures 6, 7)	-	-	0.400	Ω
Drain to Source On Voltage (Note 2)	V _{DS(ON)}	I _D = 8A, V _{GS} = -10V	-	-	3.2	٧
Turn-On Delay Time	t _{d(ON)}	I_D ≈ 4A, V_{DD} = 50V, R_G = 50Ω, V_{GS} = -10V R_L = 12Ω, (Figures 10, 11, 12)	-	18	60	ns
Rise Time	t _r		-	70	150	ns
Turn-Off Delay Time	t _{d(OFF)}		•	166	275	ns
Fall Time	t _f			94	175	ns
Input Capacitance	C _{ISS}	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz	-	-	1500	pF
Output Capacitance	c _{oss}	(Figure 9)		-	700	pF
Reverse Transfer Capacitance	C _{RSS}			-	300	pF
Thermal Resistance, Junction to Case	R ₀ JC	RFM8P08, RFM8P10	-	-	1.25	°C/W
		RFP8P08, RFP8P10	-	-	1.67	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage (Note 2)	V_{SD}	I _{SD} = -4A	-	-	-1.4	V
Diode Reverse Recovery Time	t _{rr}	$I_{SD} = -4A$, $dI_{SD}/dt = -100A/\mu s$	-	200	-	ns

NOTES:

- 2. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%
- 3. Repetitive rating: pulse width is limited by maximum junction temperature.

Typical Performance Curves

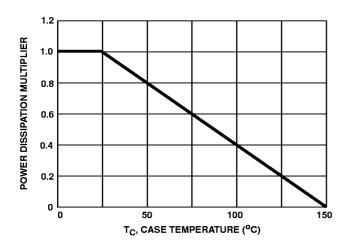


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

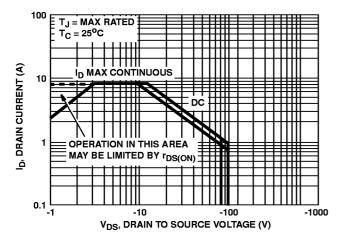


FIGURE 3. FORWARD BIAS SAFE OPERATING AREA

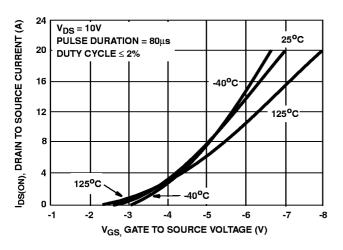


FIGURE 5. TRANSFER CHARACTERISTICS

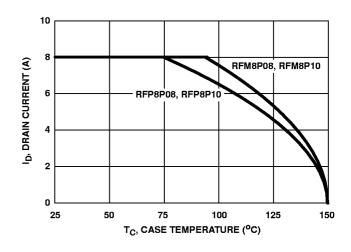


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

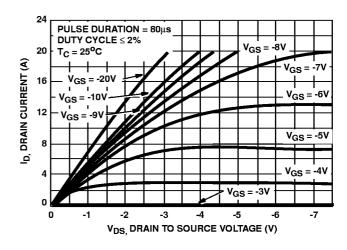


FIGURE 4. SATURATION CHARACTERISTICS

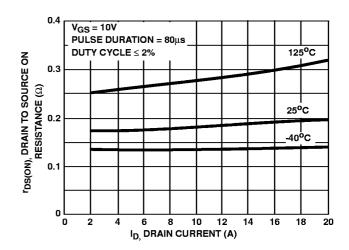


FIGURE 6. DRAIN TO SOURCE ON RESISTANCE VS DRAIN CURRENT